

XN04602

Silicon NPN epitaxial planar type (Tr1)
Silicon PNP epitaxial planar type (Tr2)

For general amplification

■ Features

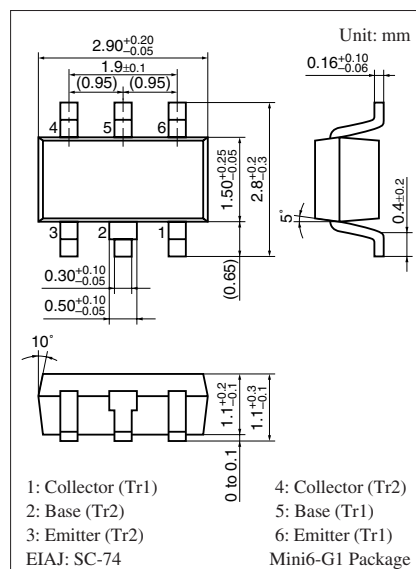
- Two elements incorporated into one package
- Reduction of the mounting area and assembly cost by one half

■ Basic Part Number

- 2SD0602A + 2SB0710A

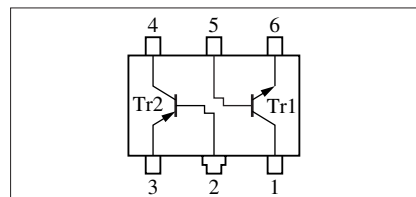
■ Absolute Maximum Ratings $T_a = 25^\circ\text{C}$

	Parameter	Symbol	Rating	Unit
Tr1	Collector-base voltage (Emitter open)	V_{CBO}	60	V
	Collector-emitter voltage (Base open)	V_{CEO}	50	V
	Emitter-base voltage (Collector open)	V_{EBO}	5	V
	Collector current	I_{C}	0.5	A
	Peak collector current	I_{CP}	1	A
Tr2	Collector-base voltage (Emitter open)	V_{CBO}	-60	V
	Collector-emitter voltage (Base open)	V_{CEO}	-50	V
	Emitter-base voltage (Collector open)	V_{EBO}	-5	V
	Collector current	I_{C}	-0.5	A
	Peak collector current	I_{CP}	-1	A
Overall	Total power dissipation	P_{T}	300	mW
	Junction temperature	T_{j}	150	$^\circ\text{C}$
	Storage temperature	T_{stg}	-55 to +150	$^\circ\text{C}$



Marking Symbol: 4A

Internal Connection



■ Electrical Characteristics $T_a = 25^\circ\text{C} \pm 3^\circ\text{C}$

• Tr1

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Collector-base voltage (Emitter open)	V_{CBO}	$I_{\text{C}} = 10\ \mu\text{A}$, $I_{\text{E}} = 0$	60			V
Collector-emitter voltage (Base open)	V_{CEO}	$I_{\text{C}} = 10\ \text{mA}$, $I_{\text{B}} = 0$	50			V
Emitter-base voltage (Collector open)	V_{EBO}	$I_{\text{E}} = 10\ \mu\text{A}$, $I_{\text{C}} = 0$	5			V
Collector-base cutoff current (Emitter open)	I_{CBO}	$V_{\text{CB}} = 20\ \text{V}$, $I_{\text{E}} = 0$			0.1	μA
Forward current transfer ratio *	h_{FE1}	$V_{\text{CE}} = 10\ \text{V}$, $I_{\text{C}} = 150\ \text{mA}$	85		340	—
	h_{FE2}	$V_{\text{CE}} = 10\ \text{V}$, $I_{\text{C}} = 500\ \text{mA}$	40			
Collector-emitter saturation voltage *	$V_{\text{CE(sat)}}$	$I_{\text{C}} = 300\ \text{mA}$, $I_{\text{B}} = 30\ \text{mA}$		0.35	0.60	V
Transition frequency	f_{T}	$V_{\text{CB}} = 10\ \text{V}$, $I_{\text{E}} = -50\ \text{mA}$, $f = 200\ \text{MHz}$		200		MHz
Collector output capacitance (Common base, input open circuited)	C_{ob}	$V_{\text{CB}} = 10\ \text{V}$, $I_{\text{E}} = 0$, $f = 1\ \text{MHz}$		6	15	pF

Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

2. *: Pulse measurement

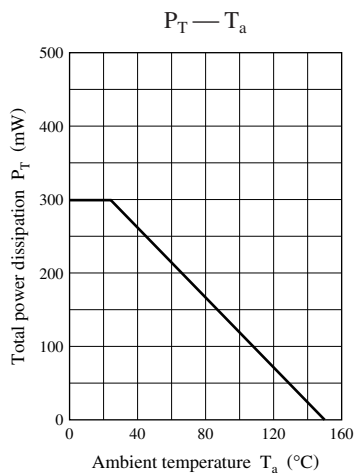
• Tr2

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Collector-base voltage (Emitter open)	V_{CBO}	$I_{\text{C}} = -10\ \mu\text{A}$, $I_{\text{E}} = 0$	-60			V
Collector-emitter voltage (Base open)	V_{CEO}	$I_{\text{C}} = -10\ \text{mA}$, $I_{\text{B}} = 0$	-50			V
Emitter-base voltage (Collector open)	V_{EBO}	$I_{\text{E}} = -10\ \mu\text{A}$, $I_{\text{C}} = 0$	-5			V
Collector-base cutoff current (Emitter open)	I_{CBO}	$V_{\text{CB}} = -20\ \text{V}$, $I_{\text{E}} = 0$			-0.1	μA
Forward current transfer ratio	h_{FE1}	$V_{\text{CE}} = -10\ \text{V}$, $I_{\text{C}} = -150\ \text{mA}$	85		340	—
	h_{FE2}	$V_{\text{CE}} = -10\ \text{V}$, $I_{\text{C}} = -500\ \text{mA}$	40			
Collector-emitter saturation voltage *	$V_{\text{CE(sat)}}$	$I_{\text{C}} = -300\ \text{mA}$, $I_{\text{B}} = -30\ \text{mA}$		-0.35	-0.60	V
Base-emitter saturation voltage *	$V_{\text{BE(sat)}}$	$I_{\text{C}} = -300\ \text{mA}$, $I_{\text{B}} = -30\ \text{mA}$		-1.1	-1.5	V
Transition frequency	f_{T}	$V_{\text{CB}} = -10\ \text{V}$, $I_{\text{E}} = 50\ \text{mA}$, $f = 200\ \text{MHz}$		200		MHz
Collector output capacitance (Common base, input open circuited)	C_{ob}	$V_{\text{CB}} = -10\ \text{V}$, $I_{\text{E}} = 0$, $f = 1\ \text{MHz}$		6	15	pF

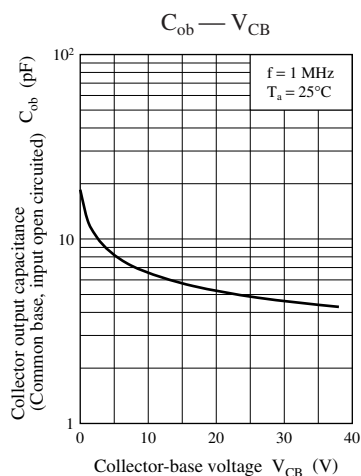
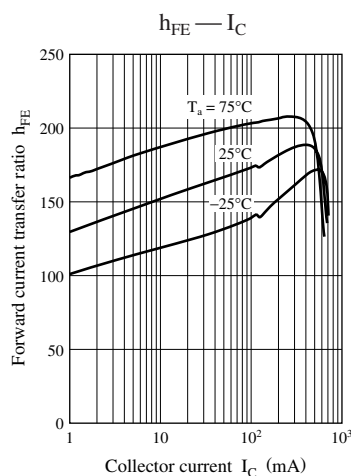
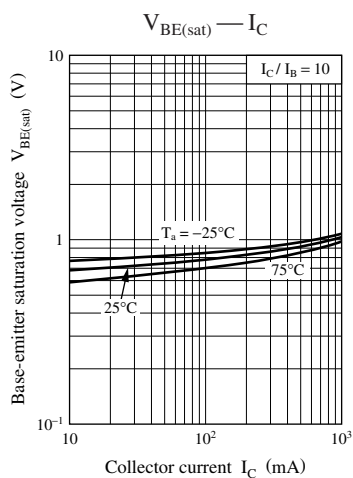
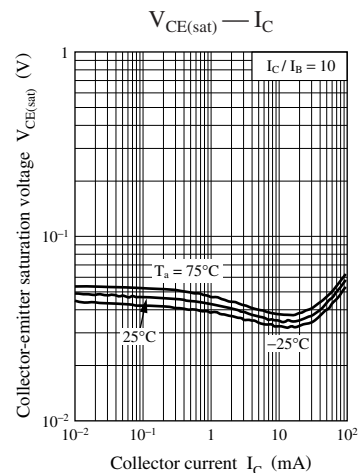
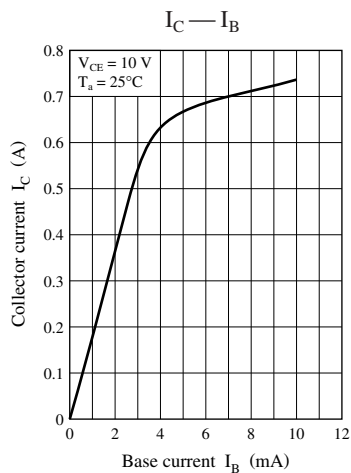
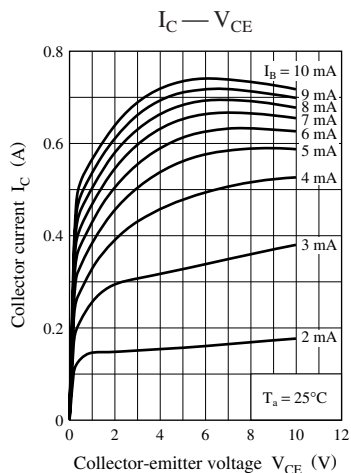
Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

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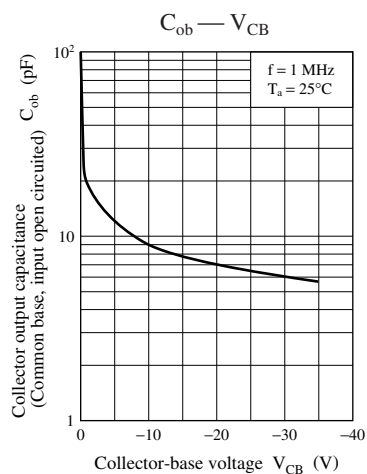
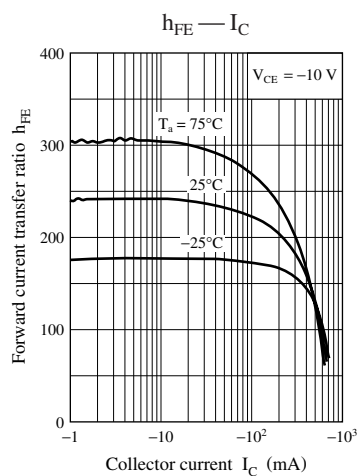
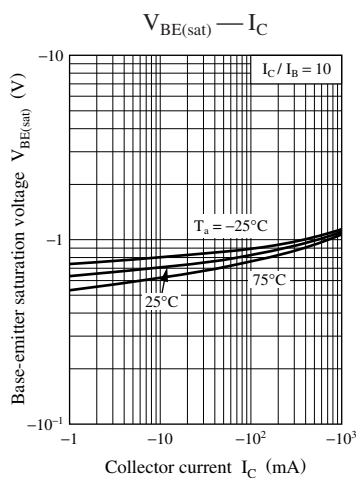
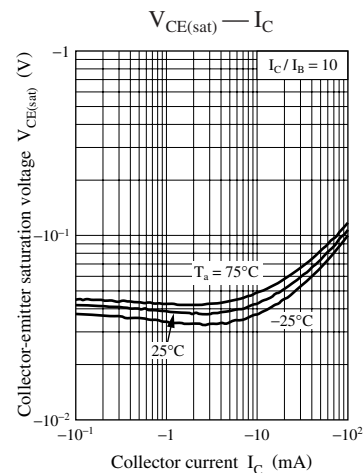
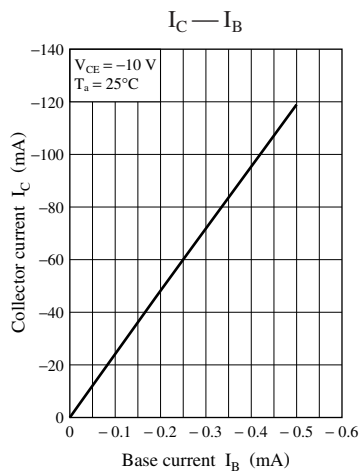
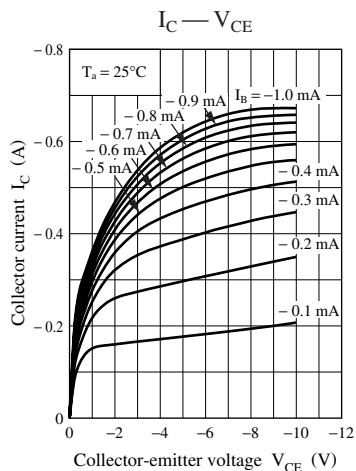
Common characteristics chart



Characteristics charts of Tr1



Characteristics charts of Tr2



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